

(Use several sheets if necessary)

Filing Date: Group: January 7, 2000 2785

U.S. Patent Documents See Page 1

Foreign Patent Documents See Page 1

Other Art See Page 1

U.S. Patent Documents

	Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date of App.
M	Wes	A1	5,751,581	05/12/98	Tau et al.	10364	113/68.22	11/13/95
M	WRS	A2	5,625,816	04/29/97	Burdick et al.	107395	1031514	04/05/94
hul	10	A3	5,442,777	08/15/95	Nakajima et al.	114395	12/182:18	02/25/94
m	Wes	A4	4,213,175	07/15/80	Kurihara	10364	PUS	06/30/78
•		A5		-				

Foreign Patent Documents

	Exam. Init.	Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No
M	WS	B1	0 932 195	07/28/99	Europe		_	
m	WS	B2	62048850	03/03/87	Japan		_	(Abstract)
	WS	В3	11119992	04/30/99	Japan		_	(Abstract)
u	WB	B4	03022064	01/30/91	Japan		_	(Abstract)
0,	7/1-	B5						

Other Art (Including Author, Title, Date Pertinent Pages, Etc.)

	Exam. Init.	Ref. Des.	Citation		
M	WS C	Cl	International Application No. PCT/US00/25736, PCT International Search Report (April 19, 2001)		
		C2	BECEIVED		
_		C3	MAY 2 0 7000		
			WAI & J 2001		

Technology Center 2100

EXAMINER:

DATE CONSIDERED:

EXAMINER: INITIAL IF REFERENCE CONSIDERED, WHETHER OF NOT CITATION IS IN CONFORMANCE WITH MPEP609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED. INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.